

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10588287	FUJINO ET AL.
	Examiner	Art Unit
	Deborah Yee	1793

SEARCHED

Class	Subclass	Date	Examiner
148	590,595,598,599,320,333-335	7/6/09	/DY/

SEARCH NOTES

Search Notes	Date	Examiner
west and inventorship search	7/6/09	/DY/

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

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